


<b>Search Notes</b>  	<b>Application/Control No.</b>  10840178	<b>Applicant(s)/Patent Under Reexamination</b>  HAMMERSTEDT ET AL.
	<b>Examiner</b>  Christopher L Chin	<b>Art Unit</b>  1641

SEARCHED			
Class	Subclass	Date	Examiner
updated search		3/14/08	CC

SEARCH NOTES		
Search Notes	Date	Examiner

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
same as above		3/14/08	CC